

QUALIFICATION TEST REPORT

CONNECTOR, EDGE CARD

501-226

Rev. A

Product Specification: 108-1248 Rev. O

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CONTROLLED DOCUMENT

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Qualification Test Report

1. Introduction

1.1 Purpose

Testing was performed on AMP* Edge Card Connector to determine its conformance to the requirements of AMP Product Specification 108-1248 Rev. O.

1.2 Scope

This report covers the electrical, mechanical, and environmental performance of the Edge Card Connector manufactured by the Printed Circuit Board Cardedge Products Division of the Capital Goods Business Unit. The testing was performed between May 20, 1993 and August 9, 1993.

1.3 Conclusion

The Edge Card Connector meets the electrical, mechanical, and environmental performance requirements of AMP Product Specification 108-1248 Rev.O.

* Trademark

1.4 Product Description

AMP Edge Card connector is a multi-contact, edge board type assembly having contacts of various lengths for plug-on, wire or solder applications. The contacts are Phosphor bronze with gold plating. The housings are Polyester.

1.5 Test Samples

The test samples were randomly selected from normal current production lots, and the following part numbers were used for test:

Test GroupQuantity Part Nbr			<u>Description</u>		
4	5	176139-1	52 Position Gold Flash		
1,4	5	176139-2	52 Position 15 microinch Gold		
1,4	5	176139-3	52 Position 30 microinch Gold		
2,3	5	176138-1	31 Position Gold Flash		
2,3	5	176138-2	31 Position 15 microinch Gold		
2,3	5	176138-3	31 Position 30 microinch Gold		

1.6 Qualification Test Sequence

		Test Groups		
Test or Examination	1	2	3	4
Examination of Product	1,9	1,5	1,5	1,9
Termination Resistance, Dry Circuit	3,7	2,4	2,4	<u></u>
Dielectric Withstanding Voltage				4,8
Insulation Resistance				3,7
Vibration	5			
Physical Shock	6			
Mating Force	2			
Unmating Force	8			
Contact Retention				2
Durability	4	<u></u>		
Thermal Shock				5_
Humidity-Temperature Cycling				6
Mixed Flowing Gas			3	
Temperature Life		3		

The numbers indicate sequence in which tests were performed.

2. Summary of Testing

2.1 Examination of Product - All Groups

All samples submitted for testing were selected from normal current production lots. They were inspected and accepted by the Product Assurance Department of the Capital Goods Business Unit.

2.2 Termination Resistance, Dry Circuit - Groups 1,2,3

All termination resistance measurements, taken at 100 milliamperes DC and 50 millivolts open circuit voltage were less than 10 milliohms.

Test Group_	Nbr of _Samples _	Condition	Min_	Max	Mean
1	60	Initial	3.0	5.3	3.80
•	60	After Mechanical	3.3	4.8	4.06
2	60	Initial	3.9	7.4	5.47
_	60	After Temp Life	4.0	7.3	5.62
3	60	Initial	3.9	7.0	5.39
-	60	After Mixed Gas	4.2	7.0	5.54

All values in milliohms

2.3 Dielectric Withstanding Voltage - Group 4

No dielectric breakdown or flashover occurred when a test voltage was applied between adjacent contacts.

2.4 Insulation Resistance - Group 4

All insulation resistance measurements were greater than 5,000 megohms.

2.5 Vibration - Group 1

No discontinuities of the contacts were detected during vibration. Following vibration, no cracks, breaks, or loose parts on the connector assemblies were visible.

2.6 Physical Shock - Group 1

No discontinuities of the contacts were detected during physical shock. Following physical shock testing, no cracks, breaks, or loose parts on the connector assemblies were visible.

2.7 Mating Force - Group 1

All mating force measurements were less than 19 ounces per contact pair.

2.8 Unmating Force - Group 1

All unmating force measurements were greater than 1.25 ounces per contact pair.

2.9 Contact Retention - Group 4

No physical damage occurred to either the contacts or the housing, and no contacts dislodged from the housings as a result of supplying an axial load of 8.0 pounds to each contacts.

2.10 Durability - Group 1

No physical damage occurred to the samples as a result of mating and unmating the connector 250 times for contacts with 30 microinch gold, 100 times for contacts with 15 microinch gold, and 5 times for contacts with gold flash.

2.11 Thermal Shock - Group 4

No evidence of physical damage to either the contacts or the connector was visible as a result of thermal shock.

2.12 Humidity, Steady State - Group 4

No evidence of physical damage to either the contacts or the connector was visible as a result of exposure to a steady state humidity environment.

2.13 Mixed Flowing Gas - Group 3

No evidence of physical damage to either the contacts or the connector was visible as a result of exposure to the pollutants of mixed flowing gas.

2.14 Temperature Life - Group 2

No evidence of physical damage to either the contacts or the connector was visible as a result of exposure to an elevated temperature.

3. Test Methods

3.1 Examination of Product

Product drawings and inspection plans were used to examine the samples. They were examined visually and functionally.

3.2 Termination Resistance, Low Level

Termination resistance measurements at low level current were made using a four terminal measuring technique (Figure 1). The test current was maintained at 100 milliamperes DC with an open circuit voltage of 50 millivolts DC.

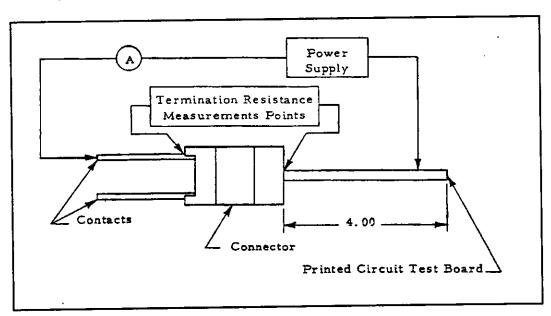


Figure 1
Typical Termination Resistance Measurement Points

3.3 <u>Dielectric Withstanding Voltage</u>

A test potential of 1000 vac was applied between the adjacent contacts. This potential was applied for one minute and then returned to zero.

3.4 <u>Insulation Resistance</u>

Insulation resistance was measured between adjacent contacts, using a test voltage of 500 volts DC. This voltage was applied for two minutes before the resistance was measured.

3.5 Vibration, Random

Connectors mated with test boards were subjected to a random vibration test, specified by a random vibration spectrum, with excitation frequency bounds of 50 and 2000 hertz. The power spectral density at 50 hz is $0.015~\rm G^2/Hz$. The spectrum slopes up at 6 Db per octave to a PSD of $0.06~\rm G^2/Hz$ at $100~\rm Hz$. The spectrum is flat at $0.06~\rm G^2/Hz$ from $100~\rm to$ $1000~\rm Hz$. The spectrum slopes down at 6 dB per octave to the upper bound frequency of 2000 Hz, at which the PSD is $0.015~\rm G^2/Hz$. The root-mean square amplitude of the excitation was $9.26~\rm GRMS$. The sample were vibrated for a period of 3 minutes in each of 3 mutually perpendicular axes for a total of 9 minutes.

3.6 Physical Shock

Connectors mated with test boards were subjected to a physical shock test, having a half-sine waveform of 50 gravity units (g peak) and a duration of 11 milliseconds. Three shocks in each direction were applied along the three mutually perpendicular planes, for a total of 18 shocks. The connectors were monitored for discontinuities greater than one microsecond, using a current of 100 milliamperes in the monitoring circuit.

3.7 <u>Mating Force</u>

The force required to fully mate a test board to each connectors was measured, using a free floating fixture with the rate of travel at 0.5 inch/minute. The maximum average force per contact was calculated.

3.8 Unmating Force

The force required to unmate a test board from each connectors was measured using a free floating fixture with the rate of travel at 0.5 inch/minute.

3.9 Contact Retention

An axial load of 8.0 pounds was applied to each contact and held for 60 seconds. The force was applied in a direction to cause removal of the contacts from the housing.

3.10 Durability

Connectors, with 30 microinch gold plating, and test boards were mated and unmated 250 times at a rate not exceeding 500 per hour.

Connectors, with 15 microinch gold plating, and test boards were mated and unmated 100 times at a rate not exceeding 500 per hour.

Connectors, with gold flash plating, and test boards were mated and unmated 5 times at a rate not exceeding 500 per hour.

3.11 Thermal Shock

Unmated connectors were subjected to 5 cycles of temperature extremes with each cycle consisting of 30 minutes at each temperature. The temperature extremes were -55°C and 85°C. The transition between temperatures was less than one minute.

3.12 Humidity, Steady State

Unmated connectors were subjected to a relative humidity of 90-95% and a temperature of 40°C for a period of 4 days.

3.13 Mixed Flowing Gas, Class II

Connectors mated with test boards were exposed for 14 days to a mixed flowing gas Class II exposure. Class II exposure is defined as a temperature of 30° C and a relative humidity of 70% with the pollutants of C1₂ at 10 ppb, NO₂ at 200 ppb, and H₂S at 10 ppb. Samples were preconditioned with 5 cycles of durability.

3.14 Temperature Life

Connectors mated with test boards were exposed to a temperature of 85°C for 500 hours. Samples were preconditioned with 5 cycles of durability.